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Power MOSFET 75 Amps, 30 Volts

N-Channel TO-220 and D²PAK

This Logic Level Vertical Power MOSFET is a general purpose part that provides the "best of design" available today in a low cost power package. Avalanche energy issues make this part an ideal design in. The drain-to-source diode has a ideal fast but soft recovery.

Features

- Ultra-Low R_{DS(on)}, Single Base, Advanced Technology
- SPICE Parameters Available
- Diode is Characterized for Use in Bridge Circuits
- I_{DSS} and V_{DS(on)} Specified at Elevated Temperatures
- High Avalanche Energy Specified
- ESD JEDAC Rated HBM Class 1, MM Class B, CDM Class 0
- Pb–Free Packages are Available

Typical Applications

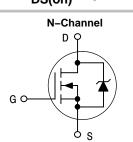
- Power Supplies
- Inductive Loads
- PWM Motor Controls
- Replaces MTP75N03HDL and MTB75N03HDL in Many Applications

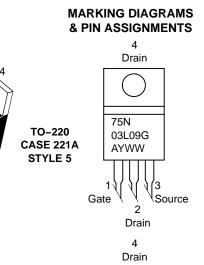


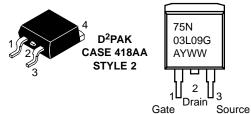
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75 AMPERES, 30 VOLTS R_{DS(on)} = 8 m Ω







75N03L09 A Y	= Device Code = Assembly Location = Year
WW	= Work Week
G	= Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	30	Vdc
Drain-to-Gate Voltage (RGS = 10 M Ω)	V _{DGB}	30	Vdc
Gate-to-Source Voltage - Continuous	V _{GS}	±20	Vdc
Non–repetitive (tp \leq 10 ms)	V _{GS}	±24	Vdc
Drain Current – Continuous @ $T_C = 25^{\circ}C$ – Continuous @ $T_C = 100^{\circ}C$ – Single Pulse (tp $\leq 10 \ \mu$ s)	I _D I _D I _{DM}	75 59 225	Adc Apk
Total Power Dissipation @ $T_C = 25^{\circ}C$ Derate above $25^{\circ}C$ Total Power Dissipation @ $T_A = 25^{\circ}C$ (Note 1)	P _D	125 1.0 2.5	W W/°C W
Operating and Storage Temperature Range	$T_{\rm J}$ and $T_{\rm stg}$	-55 to 150	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 38$ Vdc, $V_{GS} = 10$ Vdc, L = 1 mH, I _L (pk) = 55 A, $V_{DS} = 40$ Vdc)	E _{AS}	1500	mJ
Thermal Resistance – Junction–to–Case – Junction–to–Ambient – Junction–to–Ambient (Note 1)	R _{θJC} R _{θJA} R _{θJA}	1.0 62.5 50	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	ΤL	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.1. When surface mounted to an FR4 board using the minimum recommended pad size.

ORDERING INFORMATION

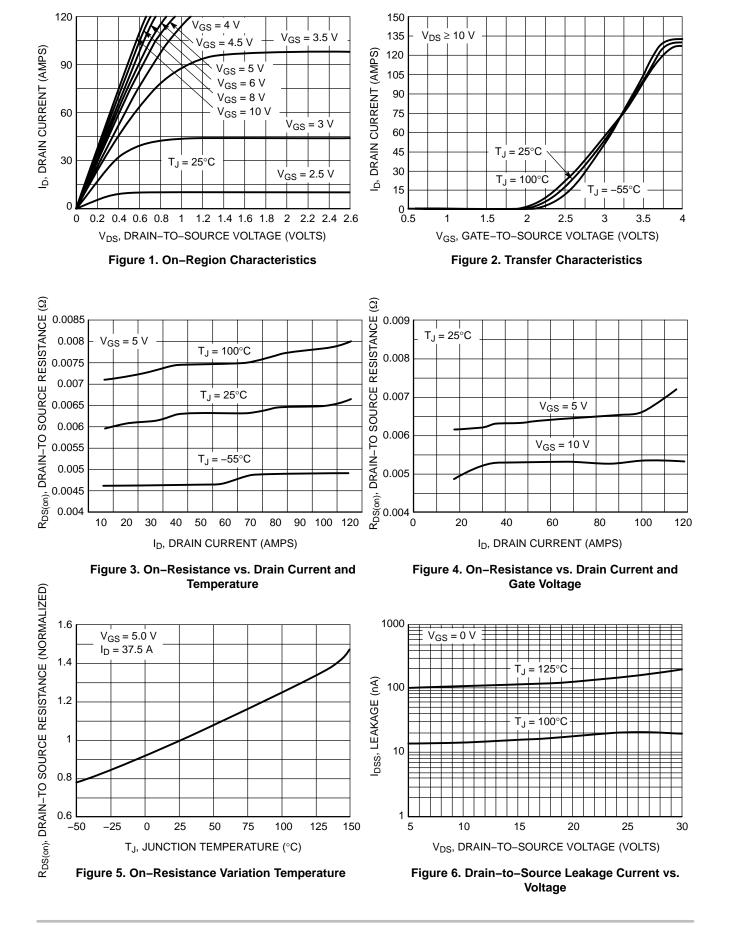
Device	Package	Shipping [†]
NTP75N03L09	TO-220	50 Units/Rail
NTP75N03L09G	TO-220 (Pb-Free)	50 Units/Rail
NTB75N03L09	D ² PAK	50 Units/Rail
NTB75N03L09G	D ² PAK (Pb–Free)	50 Units/Rail
NTB75N03L09T4	D ² PAK	800 Tape & Reel
NTB75N03L09T4G	D ² PAK (Pb–Free)	800 Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
$ \begin{array}{l} \text{Drain-Source Breakdown Voltage (Note 2)} \\ (V_{GS} = 0 \ \text{Vdc}, \ I_D = 250 \ \mu\text{Adc}) \\ \text{Temperature Coefficient (Negative)} \end{array} $			30	34 -57	- -	Vdc mV°C
Zero Gate Voltage Drain Curre $(V_{DS} = 30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$		I _{DSS}			1.0 10	μAdc
Gate-Body Leakage Current	$(V_{GS} = \pm 20 \text{ Vdc}, V_{DS} = 0 \text{ Vdc})$	I _{GSS}	-	-	±100	nAdc
ON CHARACTERISTICS (Note	2)					
Gate Threshold Voltage (Note $(V_{DS} = V_{GS}, I_D = 250 \mu Adc)$ Threshold Temperature Coeffic	,	V _{GS(th)}	1.0 -	1.6 -6	2.0	Vdc mV°C
Static Drain-to-Source On-Re $(V_{GS} = 5.0 \text{ Vdc}, I_D = 37.5 \text{ Ac})$		R _{DS(on)}	_	6.5	8.0	mΩ
Static Drain-to-Source On Resistance (Note 2) ($V_{GS} = 10 \text{ Vdc}, I_D = 75 \text{ Adc}$) ($V_{GS} = 10 \text{ Vdc}, I_D = 37.5 \text{ Adc}, T_J = 125^{\circ}\text{C}$)		V _{DS(on)}		0.52 0.35	0.68 0.50	Vdc
Forward Transconductance (Notes 2 & 4) $(V_{DS} = 3 \text{ Vdc}, I_D = 20 \text{ Adc})$			_	58	_	mΩ
DYNAMIC CHARACTERISTIC	S (Note 4)					
Input Capacitance		C _{iss}	_	4398	5635	pF
Output Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0, f = 1.0 MHz)	C _{oss}	-	1160	1894	
Transfer Capacitance		C _{rss}	-	317	430	
SWITCHING CHARACTERIST	ICS (Notes 3 & 4)		-		-	
Turn-On Delay Time		t _{d(on)}	-	16	30	ns
Rise Time	(V _{GS} = 5.0 Vdc, V _{DD} = 20 Vdc, I _D = 75 Adc,	t _r	-	130	200	
Turn-Off Delay Time	$R_{G} = 4.7 \Omega$ (Note 2)	t _{d(off)}	-	65	110	
Fall Time		t _f	-	105	175	
Gate Charge	(V _{GS} = 5.0 Vdc, I _D = 75 Adc, V _{DS} = 24 Vdc) (Note 2)	Q _T	_	57	75	nC
		Q ₁	-	11	15	
		Q ₂	_	34	50	
SOURCE-DRAIN DIODE CHA	RACTERISTICS		-		-	
Forward On–Voltage	$(I_{S} = 75 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_{S} = 75 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_{J} = 125^{\circ}\text{C})$ (Note 2)	V _{SD}	-	1.19 1.09	1.25 -	Vdc
Reverse Recovery Time		t _{rr}	-	37	-	ns
(Note 4)	(I _S = 75 Adc, V _{GS} = 0 Vdc dI _S /dt = 100 A/µs) (Note 2)	t _a	-	20	-	
Reverse Recovery Stored		t _b	-	17	-	μC
Charge (Note 4)		Q _{RR}	_	0.023	_	

Pulse Test: Pulse Width ≤ 300 μS, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.
From characterization test data.



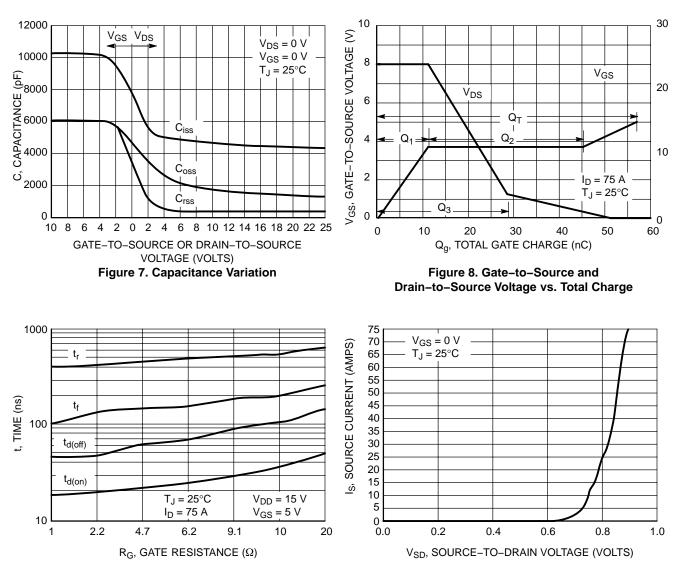
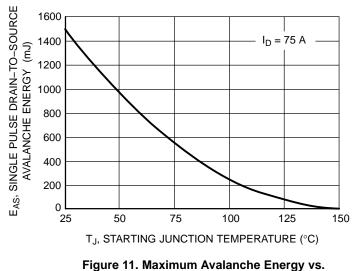


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

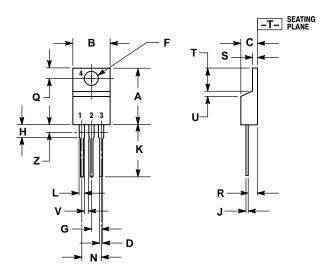




Starting Junction Temperature

PACKAGE DIMENSIONS

TO-220 CASE 221A-09 ISSUE AA



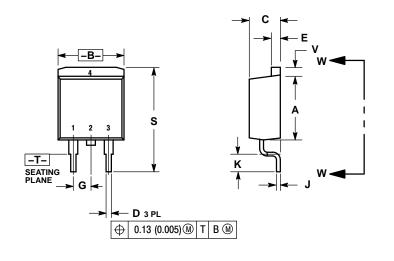
NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.570	0.620	14.48	15.75	
В	0.380	0.405	9.66	10.28	
С	0.160	0.190	4.07	4.82	
D	0.025	0.035	0.64	0.88	
F	0.142	0.147	3.61	3.73	
G	0.095	0.105	2.42	2.66	
Η	0.110	0.155	2.80	3.93	
J	0.018	0.025	0.46	0.64	
Κ	0.500	0.562	12.70	14.27	
L	0.045	0.060	1.15	1.52	
Ν	0.190	0.210	4.83	5.33	
Q	0.100	0.120	2.54	3.04	
R	0.080	0.110	2.04	2.79	
S	0.045	0.055	1.15	1.39	
Т	0.235	0.255	5.97	6.47	
U	0.000	0.050	0.00	1.27	
۷	0.045		1.15		
Ζ		0.080		2.04	

STYLE 5: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

PACKAGE DIMENSIONS

D²PAK CASE 418AA-01 ISSUE O

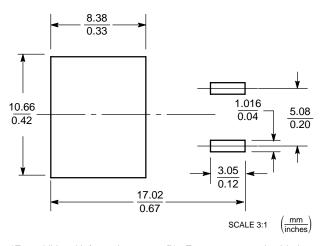


NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
С	0.160	0.190	4.06	4.83
D	0.020	0.036	0.51	0.92
Е	0.045	0.055	1.14	1.40
F	0.310		7.87	
G	0.100 BSC		2.54 BSC	
J	0.018	0.025	0.46	0.64
Κ	0.090	0.110	2.29	2.79
Μ	0.280		7.11	
S	0.575	0.625	14.60	15.88
V	0.045	0.055	1.14	1.40

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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